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Final Program



ISQED

2013

14th International Symposium on

**QUALITY
ELECTRONIC
DESIGN**

March 4-6, 2013

Techmart, Santa Clara, CA USA

**Leading Innovation & Quality in
Electronic Design™**

International Society for Quality Electronic Design
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CALL FOR PAPERS

ASQED 2013

5th Asia Symposium & Exhibits on

QUALITY ELECTRONIC DESIGN

Aug. 26-28, 2013. Penang, Malaysia



Paper Submission Deadline: April 23, 2013

Acceptance Notifications: May 23, 2013

Final Camera-Ready paper: June 16, 2013

A pioneer and leading interdisciplinary electronic design and semiconductor conference in Asia, ASQED accepts and promotes papers in following areas:

- ❖ *Advanced IC Packaging Technology*
- ❖ *Advanced 3D ICs & 3D Packaging*
- ❖ *FPGA Architecture, Design, and CAD*
- ❖ *Test & Verification*
- ❖ *Design for Test and BIST*
- ❖ *Photovoltaic Technology & Manufacturing*
- ❖ *PCB and PWB Technology & Manufacturing*
- ❖ *Circuit & System Design*
- ❖ *EDA Methodologies, Tools, Flows*
- ❖ *Semiconductor & Nano Technology*
- ❖ *Micro/NANO-Electro-Mechanical System (MEMS/NEMS)*
- ❖ *Bio Electronics Innovations*

Papers are published in ASQED proceedings and IEEE Xplore. Please visit www.asqed.com for more information.

Sponsoring Organizations:



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CALL FOR PAPERS

ISQED 2014
15th International Symposium & Exhibits on
QUALITY ELECTRONIC DESIGN

March 2014. Santa Clara, CA, USA



Paper Submission Deadline: Sept. . 12, 2013
Acceptance Notifications: November 25, 2013
Final Camera-Ready paper: January 10, 2014

A pioneer and leading interdisciplinary electronic design and semiconductor conference, ISQED accepts and promotes papers in following areas:

- ❖ *System-level Design, Methodologies & Tools*
- ❖ *FPGA Architecture, Design, and CAD*
- ❖ *Design of Embedded Systems*
- ❖ *Advanced 3D ICs & 3D Packaging, and Co-Design*
- ❖ *Robust & Power-conscious Circuits & Systems*
- ❖ *Emerging/Innovative Device Technologies and Design Issues*
- ❖ *Design of Reliable Circuits and Systems*
- ❖ *IP Design, quality, interoperability and reuse*
- ❖ *Design Verification and Design for Testability*
- ❖ *Physical Design, Methodologies & Tools*
- ❖ *EDA Methodologies, Tools, Flows*
- ❖ *Design for Manufacturability/Yield & Quality*
- ❖ *Effects of Technology on IC Design, Performance, Reliability, and Yield*

Papers from past ISQED events are published in ISQED proceedings and IEEE Xplore. Please visit www.isqed.org for more information.

WELCOME TO ISQED 2013

On behalf of the ISQED 2013 conference and technical committees, we are pleased to welcome you to the 14th International Symposium on Quality Electronic Design, ISQED 2013. This conference is the premier multidisciplinary design and design automation conference, aimed at bridging the gap between and integration of, electronic design tools and processes, integrated circuit technologies, processes, and manufacturing, to achieve design quality.

ISQED continues to provide and foster a unique opportunity to participants to interact and engage themselves in cutting edge tutorials, presentations, and plenary sessions. The conference topics provide a holistic approach while covering a wide variety of issues impacting the quality of electronic design. We thank you for your support and anticipate your continued participation through the coming years.

All the technical presentations, plenary sessions, tutorials and related events will take place on March 4-6 at the Network Meeting Center in Santa Clara, CA. Please refer to the conference booklet and/or ISQED website for program details.

We would like to thank the ISQED 2013 corporate sponsors: IBM, InnovoTek, Mentor Graphics, Synopsys, and Silicon Valley Technical Institute, and for their valuable support of this conference.

Welcome to another stellar year of ISQED! It couldn't have happened without your support and participation.

Mark Budnik
TPC Chair

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General Chair

Syed M. Alam
TPC Co-Chair

Rasit Topaloglu
Tutorial Chair

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Plenary Chair

Rajiv Joshi
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Pallab Chatterjee
Affiliate Relations

Paul Wesling
Publication Chair

Ali A. Iranmanesh
ISQED Founder

4A.1

Peak Power Reduction of a Sensor Network Processor Fabricated With Deeply Depleted Channel Transistors in 65nm Technology

*Kentaro Kawakami, Takeshi Shiro, Hironobu Yamasaki, Katsuhiro Yoda, Hiroaki Fujimoto,
Kenichi Kawasaki, Yasuhiro Watanabe*

Fujitsu Laboratories Ltd.

4A.3

Cost-effective 45nm 6T-SRAM Reducing 50mV V_{min} and 53% Standby Leakage with multi-Vt Asymmetric Halo MOS and Write Assist Circuitry

*Koji Nii¹, Makoto Yabuuchi¹, Hidehiro Fujiwara¹, Yasumasa Tsukamoto¹, Yuichiro Ishii¹,
Tetsuya Matsumura¹, Yoshio Matsuda²*

¹Renesas Electronics Corporation, ²Kanazawa University

3A.1

LMgr: A Low-Memory Global Router with Dynamic Topology Update and Bending-Aware Optimum Path Search

Jingwei Lu¹ and Chiu-Wing Sham²

¹University of California, San Diego,

²The Hong Kong Polytechnic University

* Authors of best papers are honored during the luncheon on Tuesday March 5

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do Rio Grande do Sul, Brazil

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DSO

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EDA Methodologies, Tools, Flows & IP Cores; Interoperability and Reuse (EDA)

James Lei, Applied Harmonics Corp (Chair)
Anand Iyer, Advanced Micro Devices (Co-Chair)

Committee Members:

Murat Becer - Gear DS
Yici Cai - Tsinghua University
Ritochit Chakraborty - Intel Corp.
Deming Chen - University of Illinois, Urbana-Champaign
Mely Chen Chi - Chung Yuan Christian University
Minsik Cho - IBM
Eui-Young Chung - Yonsei University
Debasish Das - Synopsys Inc
Mohana Asha Latha Dubasi - North Dakota State University
Zhuo Feng - Michigan Technological University
Masahiro Fujita - University of Tokyo
Maziar Goudarzi - Sharif University of Technology
Kanupriya Gulati - Intel
Srinivas Katkoori - University of South Florida
Eren Kursun - IBM Research
Hui Li - Intel
Abadir Magdy - Freescale Semiconductor
Mohammad Mansour - American University of Beirut
Aswin Mehta - Texas Instruments
Janet Meiling - University of Arizona
Karo Okobiah - University of North Texas
Sanghamitra Roy - Utah State University
Ahmed Shebaita - Synopsys
Malay Tripathy - Department of Electronics and Communication Engineering, Amity School of Engineering and Technology, Amity University, Noida, India
Shireesh Verma - Conexant Systems
Per Viklund - Mentor Graphics
Klaus Waldschmidt - Technische Informatik an der Universität Frankfurt
Jane Wang - Cadence
Jia Wang - Illinois Institute of Technology
Hua Xiang - IBM

Design for Manufacturability/Yield & Quality (DFMQ)

Peter Wright, Synopsys (Chair)
Siddharth Garg, University of Waterloo (Co-Chair)

Committee Members:

Rajan Beera - Texas Instruments
Kevin Brelsford - Synopsys
Brian Cline - ARM
Dhruva Ghai - Oriental University, Indore, India
Jimson Mathew - University of Bristol
Hidetoshi Matsuoka - Fujitsu Laboratories Ltd
Saraju Mohanty - University of North Texas
Fedor Pikus - Mentor Graphics
Takashi Sato - Kyoto University
Jay Sivagnaname - Freescale Semiconductor
Mustafa Berke Yelten - Intel Corporation
Vladimir Zolotov - IBM

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Design Verification and Design for Testability (DVFT)

Srivatsa Vasudevan, Synopsys (Chair)
Sreejit Chakravarty, LSI Logic (Co-Chair)

Committee Members:

George Alexiou - Univ. of Patras, Dept. of Computer Eng & Informatics
Ateet Bhalla - Oriental Institute of Science & Technology, Bhopal, India.
Alberto Bosio - LIRMM - UM2
Daniela De Venuto - Politecnico di Bari, Italy and INFN Bari, Italy
Serge Demidenko - RMIT International University Vietnam
Narendra Devta Prasanna - LSI Logic
Moiz Khan - Synopsys
Suriya Natarajan - Intel Corporation
Ganesh Subramaniyam - Intel Corporation
Spyros Tragoudas - Southern Illinois University
Miroslav Velev - Aries Design Automation
Arnaud Virazel - Montpellier Laboratory of Informatics
Charles H.-P. Wen - National Chiao Tung University

Power-conscious Devices, Interconnects, and Circuits (PCC)

Dinesh Somasekhar, Intel (Chair)

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Ali Afzali-Kusha - University of Tehran
Amir Ajami - Synopsys, Inc.
Amin Khajeh - Intel Labs
Volkan Kursun - Hong Kong University of Science and Technology
Chi-Un Lei - University of Hong Kong
Weiping Shi - Texas A&M University
Jawar Singh - Indian Institute of Information Technology, India
Krishnan Sundaresan - Oracle America, Inc.
Sheldon Tan - University of California at Riverside
Mahalingam Venkataraman - Tensilica
Cheng Zhuo - Intel

Package - Design Interactions & Co-Design (PDI)

Farhang Yazdani, BroadPak (Chair)
John Park, Mentor Graphics (Co-Chair)

Committee Members:

Syed M. Alam - Everspin Technologies, Inc.
Ryan Coutts - Qualcomm
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Manuel Luschas - Broadcom
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Physical Design, Methodologies & Tools (PDM)

Martin Wong, University of Illinois (Chair)

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Makoto Ikeda - University of Tokyo
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Srini Krishnamoorthy - Advanced Micro Devices
Yu-Min Lee - National Chiao Tung University
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Andre Reis - UFRGS
Renato Ribas - UFRGS
Tan Yan - Synopsys, Inc.
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Mark Young - Texas Instruments
Min Zhao - Oracle Corporation

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Pascale Francis - Texas Instruments
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Nikos Konofaos - Aristotle University of Thessaloniki
Yiming Li - National Chiao Tung University
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Arijit Raychowdhury - Georgia Institute of Technology
Rasit O. Topaloglu - IBM
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Cindy-Yang Yi - University of Missouri – Kansas City

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Makram Mansour - Texas Instruments
Tinoosh Mohsenin - University of Maryland Baltimore County
Antonio Nunez - IUMA/University Las Palmas GC
Sudeep Pasricha - Colorado State University
Jose Silva Matos - University of Porto, Portugal
Bin Wu - AMD

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Design of Reliable Circuits and Systems (DFR)

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Shiyan Hu, Michigan Tech University (Co-Chair)

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Rajesh Garg - Intel

Abhilash Goyal - Oracle

Ajay Joshi - Boston University

Rouwaida Kanj - American University of Beirut

Seung-Eun Lee - Seoul National University of Science and Technology

Riaz Naseer - Intel Corp

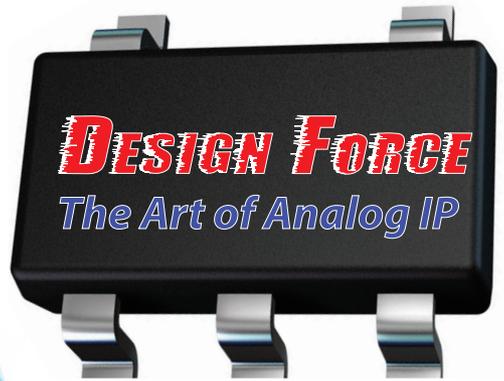
Valeriy Sukharev - Mentor Graphics

Haibo Wang - Southern Illinois University

Lei Wang - University of Connecticut

Yu Wang - Tsinghua University

Payman Zarkesh-Ha - University of New Mexico



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GENERAL INFORMATION

ISQED 2013 GENERAL INFORMATION

March 4-6, 2013
Techmart
5101 Great America Parkway, Santa Clara, CA

TUTORIALS

Monday Tutorials

Monday, March 4, 9:00am-6:00pm

Room: Fremont

Chair & Moderator:
Rasit Topaloglu - IBM

IC Technology at New Nodes Made Easy

Dr. Alvin Loke, AMD

Physical Design Considerations for Silicon Nanophotonic Circuits

Dr. Ron Ho, Oracle

Design of 3D ICs: From Concept to Practice

Prof. Sung Kyu Lim, Georgia Tech

Computer Architecture Design Utilizing Novel Memories

Prof. Engin Ipek, University of Rochester

Hardware Security and Implications on Design Flows

Prof. Ozgur Sinanoglu, NYU Abu Dhabi

Holistic Power Management: The Future of Handhelds and other Low Power Devices

Dr. Vinod Viswanath, Realintert
Rajeev D. Muralidhar, Intel
Hari Seshadri, Intel

KEYNOTE SPEECHES

Plenary Session 1P

Tuesday, March 5, 8:30am - 10:00am

Room: Silicon Valley

The Changing Device Technology

Prof. Chenming Hu
TSMC Distinguished Professor of Graduate School
University of California, Berkeley

Sustaining Innovation for Smarter Computing in Data Centers

Brad L Brech
Member of the IBM Academy of Technology
IBM

System Level Perspective on Semiconductors for Intelligent Networks

Bill Swift
Vice President of Engineering
Cisco Systems

ISQED LUNCHEON

Tuesday, March 5, 12:00pm-12:45pm
Room: Silicon Valley

ISQED AWARDS CEREMONY

Tuesday, March 5, 12:00pm-12:45pm
Room: Silicon Valley

ISQED Best Paper Awards

Recipients of the ISQED 2013 Best Paper Award will be recognized during the ISQED luncheon on Tuesday. List of best papers is shown in Page 2 of this document.

GENERAL INFORMATION

LUNCHEON KEYNOTE SPEECH

Tuesday, March 5, 12:45pm-1:30pm

Room: Silicon Valley

Trends in Analog/ Mixed-Signal Design Tools

Ed Petrus

Director of Custom Architecture, DSM division

Mentor Graphics

KEYNOTE SPEECHES

Plenary Session 2P

Wednesday, March 6, 9:00am - 10:00am

Room: Silicon Valley

Physical-Aware, High-Capacity RTL Synthesis for Advanced Nanometer Designs

Sanjiv Taneja

Vice President, Product Engineering,
Front End Design

Cadence Design Systems

The Lifecycle Of Audio Products, Consumer versus Professional

Perry Goldstein

Director of Sales & Marketing

Marshall Electronics

TECHNICAL SESSIONS

There are a total of 18 technical sessions held on Tuesday and Wednesday. Technical sessions are held in the format of 3 parallel tracks in **San Jose, New Almaden, , Morgan Hill** rooms.

Poster Papers & Mixer

Poster display will take place on Tuesday afternoon 5:00pm-7:00pm in the Atrium area outside of **New Almaden/Monte Sereno** rooms. Authors will be available to discuss their works and to answer questions. Refreshments will be served.

ON-SITE REGISTRATION

Tentative time schedule of on-site registration is as follows:

Monday, March 4

7:30am-4:00pm

Tuesday, March 5

8:00am-5:00pm

Wednesday, March 6

8:00am-1:00pm

Registration desk is located on the 1st floor Atrium beside the **Silicon Valley** room.

Co-located Events



3rd Interdisciplinary Engineering Design Education Conference

March 4-5

Rooms: Silicon Valley, San Jose, New Almaden,
Fremont

www.IEDEC.org



Sensors - Technology, Design, and Application Conference

March 6

Rooms: Fremont

www.SensorsCon.org

PROGRAM AT A GLANCE

ISQED 2013 PROGRAM AT A GLANCE					
DATE	TIME	TUTORIALS			
MONDAY 3/4/2013	9:00AM-5:00PM	BEST DESIGN PRACTICES FOR MODERN INTEGRATED CIRCUITS ROOM: FREMONT			
TUESDAY 3/5/2013	8:15AM-10:00AM	PLENARY SESSION 1P (ROOM: SILICON VALLEY) KEYNOTE SPEECHES BY: CHENMING HU - UNIVERSITY OF CALIFORNIA, BERKELEY , BRAD L BRECH -IBM, BILL SWIFT -CISCO SYSTEMS			
	10:00AM-10:20AM	MORNING BREAK			
	10:20AM-12:00PM	<table border="1"> <tr> <td> SESSION 1A 3D CIRCUITS AND PACKAGING ROOM: SAN JOSE </td> <td> SESSION 1B AGING AWARE DESIGN ROOM: NEW ALMADEN </td> <td> SESSION 1C 3D INTEGRATED CIRCUITS ROOM: MORGAN HILL </td> </tr> </table>	SESSION 1A 3D CIRCUITS AND PACKAGING ROOM: SAN JOSE	SESSION 1B AGING AWARE DESIGN ROOM: NEW ALMADEN	SESSION 1C 3D INTEGRATED CIRCUITS ROOM: MORGAN HILL
	SESSION 1A 3D CIRCUITS AND PACKAGING ROOM: SAN JOSE	SESSION 1B AGING AWARE DESIGN ROOM: NEW ALMADEN	SESSION 1C 3D INTEGRATED CIRCUITS ROOM: MORGAN HILL		
	12:00PM-12:45PM	ISQED LUNCHEON BEST PAPER AWARDS , COMMITTEE RECOGNITION AWARDS (ROOM: SILICON VALLEY)			
	12:45PM-1:30PM	LUNCHEON KEYNOTE TRENDS IN ANALOG/ MIXED-SIGNAL DESIGN TOOLS ED PETRUS - MENTOR GRAPHICS			
	1:30PM-3:30PM	<table border="1"> <tr> <td> SESSION 2A SYSTEM LEVEL DESIGN/ OPTIMIZATION FOR ENERGY ROOM: SAN JOSE </td> <td> SESSION 2B LOW POWER SYSTEM DESIGN ROOM: NEW ALMADEN </td> <td> SESSION 2C EMERGING DEVICES AND DESIGN TECHNIQUES ROOM: MORGAN HILL </td> </tr> </table>	SESSION 2A SYSTEM LEVEL DESIGN/ OPTIMIZATION FOR ENERGY ROOM: SAN JOSE	SESSION 2B LOW POWER SYSTEM DESIGN ROOM: NEW ALMADEN	SESSION 2C EMERGING DEVICES AND DESIGN TECHNIQUES ROOM: MORGAN HILL
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	3:30PM-3:50PM	AFTERNOON BREAK			
3:50PM-5:30PM	<table border="1"> <tr> <td> SESSION 3A ADVANCES IN ROUTING AND TIMING ROOM: SAN JOSE </td> <td> SESSION 3B ROBUST DESIGN FOR FAULT TOLERANCE ROOM: NEW ALMADEN </td> <td> SESSION 3C CAD FOR 3-D ICS ROOM: MORGAN HILL </td> </tr> </table>	SESSION 3A ADVANCES IN ROUTING AND TIMING ROOM: SAN JOSE	SESSION 3B ROBUST DESIGN FOR FAULT TOLERANCE ROOM: NEW ALMADEN	SESSION 3C CAD FOR 3-D ICS ROOM: MORGAN HILL	
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5:30PM-7:00PM	POSTER PAPERS & MIXER ROOM: MAZZANINE				
WEDNESDAY 3/6/2013	8:15AM-10:00AM	PLENARY SESSION 2P KEYNOTE SPEECHES BY: SANJIV TANEJA - CADENCE DESIGN SYSTEMS, PERRY GOLDSTEIN - MARSHALL ELECTRONICS (ROOM: SILICON VALLEY)			
	10:00AM-10:20AM	MORNING BREAK			
	10:20AM-12:00PM	<table border="1"> <tr> <td> SESSION 4A LOW POWER TECHNOLOGIES ROOM: SAN JOSE </td> <td> SESSION 4B SILICON DIAGNOSIS AND TEST ROOM: NEW ALMADEN </td> <td> SESSION 4C NEW IDEAS IN CAD ROOM: MORGAN HILL </td> </tr> </table>	SESSION 4A LOW POWER TECHNOLOGIES ROOM: SAN JOSE	SESSION 4B SILICON DIAGNOSIS AND TEST ROOM: NEW ALMADEN	SESSION 4C NEW IDEAS IN CAD ROOM: MORGAN HILL
	SESSION 4A LOW POWER TECHNOLOGIES ROOM: SAN JOSE	SESSION 4B SILICON DIAGNOSIS AND TEST ROOM: NEW ALMADEN	SESSION 4C NEW IDEAS IN CAD ROOM: MORGAN HILL		
	12:00PM-1:30PM	LUNCH BREAK			
	1:30PM-3:30PM	<table border="1"> <tr> <td> SESSION 5A SYSTEM DESIGN METHODOLOGIES AND AUTOMATION ROOM: SAN JOSE </td> <td> SESSION 5B MANUFACTURING AND MODELING ISSUES OF NANOSCALE CMOS ROOM: NEW ALMADEN </td> <td> SESSION 5C MULTI-CORE AND MULTI-PROCESSOR SYSTEMS ROOM: MORGAN HILL </td> </tr> </table>	SESSION 5A SYSTEM DESIGN METHODOLOGIES AND AUTOMATION ROOM: SAN JOSE	SESSION 5B MANUFACTURING AND MODELING ISSUES OF NANOSCALE CMOS ROOM: NEW ALMADEN	SESSION 5C MULTI-CORE AND MULTI-PROCESSOR SYSTEMS ROOM: MORGAN HILL
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3:30PM-3:50PM	AFTERNOON BREAK				
3:50PM-5:30PM	<table border="1"> <tr> <td> SESSION 6A ISSUES AND CHALLENGES IN CHARACTERIZATION AND POWER INTEGRITY FOR NANOMETER TECHNOLOGIES ROOM: SAN JOSE </td> <td> SESSION 6B LOW POWER CIRCUITS ROOM: NEW ALMADEN </td> <td> SESSION 6C RELIABLE SYSTEM DESIGN ROOM: MORGAN HILL </td> </tr> </table>	SESSION 6A ISSUES AND CHALLENGES IN CHARACTERIZATION AND POWER INTEGRITY FOR NANOMETER TECHNOLOGIES ROOM: SAN JOSE	SESSION 6B LOW POWER CIRCUITS ROOM: NEW ALMADEN	SESSION 6C RELIABLE SYSTEM DESIGN ROOM: MORGAN HILL	
SESSION 6A ISSUES AND CHALLENGES IN CHARACTERIZATION AND POWER INTEGRITY FOR NANOMETER TECHNOLOGIES ROOM: SAN JOSE	SESSION 6B LOW POWER CIRCUITS ROOM: NEW ALMADEN	SESSION 6C RELIABLE SYSTEM DESIGN ROOM: MORGAN HILL			

VENDOR EXHIBITS - 3:00PM-7:00PM

MONDAY TUTORIALS

Monday, March 4, 2013

9:00AM-6:00PM

Room: Fremont

Best Design Practices for Modern Integrated Circuits

Chair & Moderator:

Rasit Topaloglu, IBM

Presenters:

Dr. Alvin Loke, AMD

Dr. Ron Ho, Oracle

Prof. Sung Kyu Lim, Georgia Tech

Prof. Engin Ipek, University of Rochester

Prof. Ozgur Sinanoglu, NYU Abu Dhabi

Dr. Vinod Viswanath, Real Intent

Rajeev D. Muralidhar, Intel

Hari Seshadri, Intel

While traditional scaling will take us a few more nodes, drastic changes in the way we design integrated circuits may be needed. For example, 3D interconnects may be needed to decrease communication costs, along with a more aggressive on-chip optical integration.

The tutorial will start by illustrating how AMD designers tackle current advanced nodes. It will then follow with a talk where Oracle researchers show how to integrate optics on chip. Next, Georgia Tech researchers present on design tools and models to design and measure 3D chips.

Novel integrated circuit design furthermore may bring changes in computing architecture. Novel memory techniques may be used as illustrated by a talk from University of Rochester. The tutorial will continue by a talk from NYU-Abu Dhabi on the trending topic of hardware security and how to secure designs and design flows. Furthermore, power management will continue to become essential and work by RealIntent and Intel will be presented to conclude the tutorial.

Tutorial 1

9:00AM-10:40AM

IC Technology at New Nodes Made Easy

Presenter:

Dr. Alvin Loke, AMD

Despite increasing economic and technical challenges in scaling CMOS, we continue to witness unprecedented performance with 22-nm fully-depleted tri-gate devices now in production. This tutorial offers a summary of how CMOS device technology has progressed over the past two decades. We will review MOS devices and short-channel fundamentals to motivate how device architectures in production have evolved to incorporate elements such as halos and spaces, mechanical strain engineering, high-K dielectric and metal gate, fully-depleted architectures, and finally trigate fins.

Tutorial 2

10:50AM-12:00PM

Physical Design Considerations for Silicon Nanophotonic Circuits

Presenter:

Ron Ho, Ph.D., Oracle Labs

Silicon nanophotonic links have recently captured the attention of designers interested in their potential energy, area, and performance advantages over electrical links. An abstracted view of a silicon nanophotonic link is straightforward, and lends itself nicely to simple and useful system models. Unsurprisingly, however, the realities of building operating photonic links contains several subtleties that are worth understanding. In this talk we will introduce photonic links, discuss their basic operation, and describe the principal physical challenges in their use. These will include resonant ring modulator tradeoffs, ring thermal stability control, efficient receiver designs, and receiver BER vs SNR.

Tutorial 3

1:00PM-2:10PM

Design of 3D ICs: From Concept to Practice

Presenter:

Prof. Sung Kyu Lim, Georgia Tech

This tutorial covers the design of through-silicon-via (TSV) based three dimensional integrated circuits. It includes details of numerous “manufacturing-ready” GDSII-level layouts of TSV-based 3D ICs, developed with CAD tools covered in this tutorial. Participants will also learn the sign-off level analysis methodologies for timing, power, signal integrity, and thermo-mechanical reliability for 3D IC designs. Coverage also includes various design-for-manufacturability (DFM), design-for-reliability (DFR), and design-for-testability (DFT) techniques that are considered critical to the 3D IC design process.

Tutorial 4

2:10PM-3:20PM

Computer Architecture Design Utilizing Novel Memories

Presenter:

Prof. Engin Ipek, University of Rochester

Continued advances in the performance of computer systems depend critically on the industry’s ability to scale memory density and capacity for decades to come. Unfortunately, scaling of semiconductor memories is increasingly affected by fundamental limits in deep-submicron process technologies. The ITRS projection predicts difficulties in scaling key DRAM process parameters, and the SIA Roadmap projects difficulties scaling Flash past the 20nm node; at 21 nanometers, small numbers of electrons (e.g., 10) tunneling from the floating gate will cause a Flash cell to lose its state. Recent work differentiates charge memories (such as DRAM, SRAM, and Flash memory), which use electric carriers to store the state of a bit, from resistive memories, which use atomic arrangements to set the resistance of a memory cell to store information. Resistive memories, which include phase-change Memory (PCM), Ferroelectric RAM (FeRAM), Spin-Torque Transfer Magnetoresistive RAM (STTMRAM), and Resistive RAM (RRAM), the latter of which includes memristors, are all candidates to succeed charge memories if and when charge memories reach fundamental limits.

To start exploiting the scalability of resistive memories, however, resistive memories must first be architected to address relatively long latencies, high energy writes, and finite endurance.

In the first half of this talk, I will examine resistive computation, an architectural technique that aims at developing a new class of power-efficient, scalable systems by migrating much of the functionality of a modern microprocessor from CMOS to STTMRAM. The key idea is to implement most of the on-chip storage and combinational logic using scalable, leakage-resistant RAM arrays and lookup tables (LUTs) constructed from STT-MRAM to lower leakage, thereby allowing many more active cores under a fixed power budget than a pure CMOS implementation could afford. I will then introduce recent work on architecting PCM as a scalable, persistent DRAM replacement. Software cognizant of this newly provided persistence can provide qualitatively new capabilities. For example, system boot/hibernate will be perceived as instantaneous; application check pointing will be inexpensive; file systems will provide stronger safety guarantees. Hence, this work is a first step toward a fundamentally new memory hierarchy with deep implications across the hardware-software interface.

Tutorial 5

3:40PM-4:50PM

Hardware Security and Implications on Design Flows

Presenter:

Prof. Ozgur Sinanoglu, NYU Abu Dhabi

Today's System on Chip (SoC) is being incorporated with digital, analog, radio frequency, photonic and other devices. More recently, sensors, actuators, and biochips are also being integrated into these already powerful SoCs. On one hand, SoC integration has been enabled by advances in mixed system integration and the increase in the wafer sizes (currently about 300 mm and projected to be 450mm by 2018). Consequently, the cost per chip of such SoCs has reduced. On the other hand, support for multiple capabilities and mixed technologies has increased the cost of ownership of advanced foundries. For instance, the cost of owning a foundry will be \$5 billion in 2015. Consequently, only large commercial foundries now manufacture such high performance, mixed system SoCs especially at the advanced technology nodes. Absent the economies of scale, many of the design companies cannot afford owning and acquiring expensive foundries and hence, outsource their design fabrication to these "one-stop-shop" foundries. This globalization of Integrated Circuit (IC) design flow has introduced security vulnerabilities. If a design is fabricated in a foundry that is outside the direct control of the (fabless) design house, reverse engineering, malicious circuit modification, and Intellectual Property (IP) piracy are possible. An attacker, anywhere in this design flow, can reverse engineer the functionality of an IC/IP, and steal and claim ownership of the IP. An untrusted IC foundry may overbuild ICs and sell the excess parts in the gray market. Rogue elements in the foundry may insert malicious circuits (hardware Trojans) into the design without the designer's knowledge. Because of these and similar hardware-based attacks, the semiconductor industry loses \$4 billion annually. In this talk, we cover Design-for-Trust techniques to regain trust in manufactured hardware. A popular approach to thwart these attacks is to conceal (encrypt) the functionality of an IC while it passes through the different, potentially untrustworthy phases of the global design flow, giving the control back to the designer. We will survey the different approaches to encrypting the functionality of a design. We will then discuss how IC (testing) fault analysis techniques can be used both as a defense aid and as an attack tool. On one hand, we will show how a designer can use VLSI fault analysis to aid the design encryption process. On the other hand, we will show that the fault analysis can be used as a weapon by an attacker to obtain the design functionality. We will also cover side channel measurement based Trojan detection approaches.

Tutorial 6

4:50PM-6:00PM

Holistic Power Management: The Future of Handhelds and other Low Power Devices

Presenters:

Dr. Vinod Viswanath, Real Intent

Rajeev D. Muralidhar, Intel

Hari Seshadri, Intel

Power efficiency is a growing concern to all aspects of computing systems ranging from the very small, highly integrated System-on-a-Chip (SoC) based handheld devices to larger systems including servers and many-core high performance computing systems. In order to maximize power optimization, the future trend is to perform holistic power management across different levels of design abstractions. This means that embedded/SoC systems that are power optimized will now be application and workload aware. The O/S will be aware of micro-architectural features to program the device in certain power and sleep states. In this tutorial, we will address the challenges of holistic power management. In particular we'll cover the challenges of a unified specification of power intent across all design abstraction levels; power optimization and holistic power management techniques; and, the challenges of verification of such a system. All three presenters have many years of experience with Intel's low power design methodologies, challenges and state-of-the-art technology. The tutorial will be amply supplemented with real life examples from Intel's experience in designing some of its latest handheld devices

KEYNOTE SPEECHES

Plenary Session 1P

Room: Silicon Valley
8:15AM-10:00AM

Keynote Speech 1P.1

Tuesday, March 5
8:30AM-9:00AM

The Changing Device Technology



Chenming Hu

TSMC Distinguished Professor of Graduate School
University of California, Berkeley

IC device technology has entered a new era of bold changes. FinFET may be the best known new technology. Ultra-thin-body is an attractive new technology. Even bolder changes are envisioned and needed to empower the semiconductor industry.

About Chenming Hu

Chenming Hu is the TSMC Distinguished Professor of UC Berkeley. He was formerly the Chief Technology Officer of TSMC. He is known for developing the 3D transistor, FinFET, that can be scaled beyond 10nm. He also developed the international-standard MOSFET model used by most IC companies since 1997. He has received the IEEE Andrew Grove Award, Solid State Circuits Award, Nishizawa Medal, and UC Berkeley's highest honor for teaching--the Berkeley Distinguished Teaching Award.

Keynote Speech 1P.2

Tuesday, March 5
9:00AM-9:30AM

Sustaining Innovation for Smarter Computing in Data Centers



Brad L Brech

Member of the IBM Academy of Technology
IBM

Better business economics and accelerated business velocity are the two most important factors to the CxO's of clients moving forward. They see technology as a key to their success in meeting both goals in this fast moving world. Smarter Computing is about successfully overcoming the challenges of new analytics, cloud, big data and security requirements through use of appropriate technologies. In the end, doing things Smarter and Faster are the driving factors for the Next Generation of Data Centers.

About Brad L Brech

Brad Brech is a Distinguished Engineer in the Systems and Technology Division of IBM in the office of the CTO. He is currently leader of the Systems and Technology Architecture board, where his responsibilities include technical strategy, energy efficient computing, intellectual property development and technical vitality for IBM STG. Brad joined IBM in 1982. He has made many contributions to the mid-range systems from the System/36, AS/400, and Power Systems families in roles from logic design, Chief Firmware architect, and Chief Systems SW Architect. As one of the drivers behind IBM's Project Big Green in 2006, he focused on development and delivery of technologies that help customers increase the level of energy efficiency in their data centers. Brad is an IBM Distinguished Engineer, a member of the IBM Academy of Technology, and a board member of The Green Grid. He has many IBM awards, serves on leadership team for the IBM Academy of Technology, and other corporate technical vitality teams. He has published several papers and reports, holds several patents. He is an alumnus Stevens Institute of Technology. Outside of work he spends time with his family and working on the boards of 3 charitable organizations.

Keynote Speech 1P.3

Tuesday, March 5
9:30AM-10:00AM

System Level Perspective on Semiconductors for Intelligent Networks



Bill Swift
Vice President of Engineering
Cisco Systems

The impact of the internet on our lives is accelerating and the innovation required to build the technologies and products for these networks is accelerating with it. Innovations at the semiconductor level, board level, and system level in support of new requirements on signaling, packaging, operation, quality, and reliability are taking analytical, simulation, and compute technologies to new limits. In this keynote, Cisco VP of Engineering Bill Swift highlights technology and business trends, as well as innovation drivers for semiconductor technology in the industry and at Cisco enabling products and solutions for intelligent networks.

About Bill Swift

Bill Swift is the Vice President of Engineering for the Silicon Engineering team in the Cisco Systems Engineering organization. He is currently responsible for silicon development engineering for the service provider, enterprise, and high end switching based products. Bill joined Cisco in 1994 and has held a number of hardware, software and system engineering leadership positions across multiple technologies, developments and platforms including the highly successful 7500, 12K, MGX, CRS, and ASR9K platforms. Prior to that, Bill has led the initial development and integration of many key service provider technologies into Cisco routing products such as packet over sonet, channelized interfaces, IP over optical, and IP over DWDM. Before joining Cisco, Bill worked in product development teams at Tandem Computers on non-stop computing, GTE Telenet on X.25 packet switching and American Satellite Company on satellite communications systems. Bill holds both Bachelor's and Master's degrees in Electrical Engineering from The Johns Hopkins University at Baltimore, Maryland.

SESSION 1A

Tuesday March 5, 2013

Three Dimensional Circuits and Packaging

Chair: **Farhang Yazdani**, BroadPak
Co-Chair: **John Park**, Mentor Graphics

10:20AM

1A.1

Hetero2 3D Integration: A Scheme for Optimizing Efficiency/Cost of Chip Multiprocessors

Shivam Priyadarshi¹, Niket Choudhary¹, Brandon Dwiell¹, Ankita Upreti¹, Eric Rotenberg², Rhett Davis³, Paul Franzon²

¹Graduate Student, North Carolina State University, Raleigh, ²Professor, North Carolina State University, Raleigh, ³Associate Professor, North Carolina State University, Raleigh

10:40AM

1A.2

Effective Thermal Control Techniques for Liquid-Cooled 3D Multi-Core Processors

Yue Hu, Shaoming Chen, Lu Peng, Edward Song, Jin-Woo Choi
Louisiana State University

11:00AM

1A.3

Reliability-Constrained Die Stacking Order in 3DICs Under Manufacturing Variability

Tuck-Boon Chan, Andrew B. Kahng, Jiajia Li
University of California, San Diego

11:20AM

1A.4

Analytical Modeling and Numerical Simulations of Temperature Field in TSV-based 3D ICs

Yuriy Shiyanovskii¹, Chris Papachristou¹, Cheng-Wen Wu²

¹Case Western Reserve University, ²National Tsing Hua University / Industrial Technology Research Institute

11:40AM

1A.5

New Electrical Design Verification Approach for 2.5D/3D Package Signal and Power Integrity

Nozad Karim
Amkor Technology

SESSION 1B

Tuesday March 5, 2013

Aging aware design

Chair: **Riza Naseer**, Intel
Co-Chair: **Srivinas Bodapati**, Intel

10:20AM

1B.1

An Arbitrary Stressed NBTI Compact Model for Analog/Mixed-Signal Reliability Simulations

Jinbo Wan and Hans Kerkhoff

Testable Design and Testing of Integrated Systems Group, University of Twente, Netherlands

10:40AM

1B.2

Impacts of NBTI and PBTI Effects on Ternary CAM

Yen-Han Lee, Ing-Chao Lin, Sheng-Wei Wang

National Cheng Kung University, Taiwan

11:00AM

1B.3

On Predicting NBTI-induced Circuit Aging by Isolating Leakage Change

Yinhe Han¹, Song Jin¹, Jiebing Qiu¹, Qiang Xu², Xiaowei Li¹

¹Institute of Computing Technology, Chinese Academy of Sciences, ²The Chinese University of Hong Kong

11:20AM

1B.4

Aging-aware Timing Analysis Considering Combined Effects of NBTI and PBTI

Saman Kiamehr, Farshad Firouzi, Mehdi B. Tahoori

Karlsruhe Institute of Technology (KIT)

11:40AM

1B.5

Flexible Data Allocation for Scratch-pad Memories to Reduce NBTI Effects

Dimitra Papagiannopoulou, Patipan Prasertsom, Iris Bahar

Brown University

SESSION 1C

Tuesday March 5, 2013

3D Integrated Circuits

Chair: **Houman Homayoun**, University of California San Diego

Co-Chair: **Jose Silva Matos**, University of Porto, Portugal

10:20AM

1C.1

Runtime 3-D Stacked Cache Management for Chip-Multiprocessors

Jongpil Jung¹, Kyungsu Kang², Giovanni De Micheli², Chong-Min Kyung¹

¹KAIST, ²EPFL

10:40AM

1C.2

A Co-Synthesis Methodology for Power Delivery and Data Interconnection Networks in 3D ICs

Nishit Kapadia and Sudeep Pasricha

Colorado State University

11:00AM

1C.3

Temperature Aware Thread Migration in 3D Architecture with Stacked DRAM

Dali Zhao¹, Houman Homayoun², Alex V. Veidenbaum¹

¹University of California, Irvine, ²George Mason University

11:20AM

1C.4

A System-level Solution for Managing Spatial Temperature Gradients in Thinned 3D ICs

Arunachalam Annamalai, Raghavan Kumar, Arunkumar Vijayakumar, Sandip Kundu

University of Massachusetts Amherst

11:40AM

1C.5

Vertically-Addressed Test Structures (VATS) for 3D IC Variability and Stress Measurements

Conor O'Sullivan, Peter Levine, Siddharth Garg

University of Waterloo

ISQED Luncheon

Tuesday March 5

Room: Silicon Valley

12:00PM-1:30PM

ISQED 2013 Award Ceremony

12:00PM-12:45PM

Best Paper Awards

Recognition Awards

Luncheon Keynote Speech

Tuesday March 5
Room: Silicon Valley
12:45PM-1:30PM

Trends in Analog/ Mixed-Signal Design Tools



Ed Petrus
Director of Custom Architecture, DSM division
Mentor Graphics

Designers who are creating analog/mixed-signal intensive designs are faced with a complex set of challenges. They need to have a high degree of confidence that their designs will be manufacturable and perform to specification in the foundry process before they even consider completing a design in an advanced process node. These ICs are often assembled using multiple resources and various design methodologies including IP reuse, top-down design, and bottom-up design. In the keynote, Ed Petrus discusses the unique challenges of designing custom ICs targeted for smaller manufacturing geometries, and talks about the tools being successfully deployed today while giving insights into what is on the horizon in terms of new functionality.

About Ed Petrus

Ed Petrus is the Director of Custom Architecture for the Deep Submicron division of Mentor Graphics. Before coming to Mentor, Ed was the co-founder of Ciranova where he helped build breakthrough products for automating custom IC physical design. These products are in deployment with design teams at top semiconductor companies using sub-40nm processes. Previous to Ciranova, Ed spent 10 years at Cadence Design Systems where he was an architect and developer of SKILL and other components of Cadence's DFII technology. Before Cadence, Ed started his career in EDA as a software engineer at Daisy Systems. Ed has held engineering management positions at Military Advantage and Nanomix. Ed holds B.Sc. and M.Sc. degrees in Computer Science from the University of Essex in the United Kingdom.

SESSION 2A
Tuesday March 5, 2013
System Level Energy

Chair: **Lech Jozwiak**, Eindhoven University of Technology

Co-Chair: **Rajesh Berigei**, Texas Instruments

1:30PM

2A.1

Energy-Aware Coarse-Grained Reconfigurable Architectures using Dynamically Reconfigurable Isolation Cells

Syed M. A. H. Jafri¹, Ozan Zeki Bag¹, Ahmed Hemani¹, Nasim Farahini¹, Kolin Paul¹, Juha Plosila², Hannu Tenhunen¹

¹Royal Institute of Technology (KTH) Sweden, ²University of Turku (UTU) Finland

1:50PM

2A.2

Hybrid CMOS-TFET based Register Files for Energy-Efficient GPGPUs

Zhi Li, Jingweijia Tan, Xin Fu

University of Kansas

2:10PM

2A.3

Compiler-assisted Leakage Energy Optimization of Media Applications on Stream Architectures

Shan Cao¹, Zhaolin Li², Zhixiang Chen¹, Guoyue Jiang¹, Shaojun Wei¹

¹Institute of Microelectronics, Tsinghua University, ²Tsinghua National Laboratory for Information Science and Technology, Research Institute of Information Technology, Tsinghua University

2:30PM

2A.4

On a Rewriting Strategy for Dynamically Managing Power Constraints and Power Dissipation in SoCs

Vinod Viswanath¹, Rajeev Muralidhar², Harinarayanan Seshadr², Jacob Abraham³

¹Real Intent Inc., ²Intel Corp., ³University of Texas at Austin

2:50PM

2A.5

Sustainable Dual-Level DVFS-enabled NoC with On-chip Wireless Links

Jacob Murray, Rajath Hegde, Teng Lu, Partha Pande, Behrooz Shirazi

Washington State University

3:10PM

2A.6

On the Selection of Adder Unit in Energy Efficient Vector Processing

Ivan Ratkovic, Oscar Palomar, Milan Stanic, Osman S. Unsal, Adrian Cristal, Mateo Valero
Barcelona Supercomputing Center

SESSION 2B

Tuesday March 5, 2013

Low Power System Design

Chair: **Amin Khajeh Djahromi**, Intel

Co-Chair: **Krishnan Sundaresan**, Oracle America, Inc.

1:30PM

2B.1

Low-Energy Digital Filter Design Based on Controlled Timing Error Acceptance

Ku He, Andreas Gerstlauer, Michael Orshansky

The University of Texas at Austin

1:50PM

2B.2

A Novel and Efficient Method for Power Pad Placement Optimization

Ting Yu and Martin. D. F. Wong

UIUC

2:10PM

2B.3

Min-Cut Based Leakage Power Aware Scheduling in High-Level Synthesis

Nan Wang¹, Song Chen², Takeshi Yoshimura¹

¹Graduate School of IPS, Waseda University, ²University of Science and Technology of China

2:30PM

2B.4

Hierarchical Dynamic Power Management Using Model-Free Reinforcement Learning

Yanzhi Wang¹, Maryam Triki², Xue Lin¹, Ahmed Ammar², Massoud Pedram¹

¹University of Southern California, ²Carthage University

2:50PM

2B.5

Accurate Architecture-level Thermal Analysis Methods for MPSoC with Consideration for Leakage Power Dependence on Temperature

Jiaqi Yan, Zuying Luo, Liang Tang

Beijing Normal University, 19 XinJieKouWai Street, Beijing, P.R.CHINA

3:10PM

2B.6

Application-Driven Power Efficient ALU Design Methodology for Modern Microprocessors

Na Gong¹, Jinhui Wang², Ramalingam Sridhar¹

¹University at Buffalo, SUNY, ²VLSI and System Lab, Beijing University of Technology

SESSION 2C

Tuesday March 5, 2013

Emerging Devices and Design Techniques

Chair: **Paul Tong**, Pericom Semiconductor

Co-Chair: **Bao Liu**, UT San Antonio

1:30PM

2C.1

Low Power and Compact Mixed-Mode Signal Processing Hardware using Spin-Neurons

Mrigank Sharad¹, Deliang Fan², Kaushik Roy²

¹Purdue University, ²Purdue Univeristy

1:50PM

2C.2

System-level Optimization and Benchmarking for InAs Nanowire Based Gate-All-Around Tunneling FETs

Chenyun Pan, Ahmet Ceyhan, Azad Naeemi

Georgia Institute of Technology

2:10PM

2C.3

Impact of Conventional and Emerging Interconnects on the Circuit Performance of Various Post-CMOS Devices

Ahmet Ceyhan and Azad Naeemi

Georgia Institute of Technology

2:30PM

2C.4

Reducing IR Drop in 3D Integration to Less Than 1/4 Using Buck Converter on Top Die (BCT) Scheme

Yasuhiro Shinozuka¹, Hiroshi Fuketa¹, Koichi Ishida¹, Futoshi Furuta², Kenichi Osada², Kenichi Takeda², Makoto Takamiya¹, Takayasu Sakurai¹

¹University of Tokyo, ²Association of Super-Advanced Electronics Technologies (ASET)

2:50PM

2C.5

Energy-Efficient Spin-Transfer Torque RAM Cache Exploiting Additional All-Zero-Data Flags

Jinwook Jung, Yohei Nakata, Masahiko Yoshimoto, Hiroshi Kawaguchi

Kobe University

3:10PM

2C.6

Design Of Ultra High Density And Low Power Computational Blocks using Nano-Magnets

Mrigank Sharad, Karthik Yogendra, Kon-Woo Kwon, Kaushik Roy

Purdue University

SESSION 3A

Tuesday March 5, 2013

Advances in Routing and Timing

Chair: **Mark Young**, Texas Instruments

Co-Chair: **Andre Reis**, Universidade Federal do Rio Grande do Sul

3:50PM

3A.1

LMgr: A Low-Memory Global Router with Dynamic Topology Update and Bending-Aware Optimum Path Search

Jingwei Lu¹ and Chiu-Wing Sham²

¹Department of Computer Science and Engineering, University of California, San Diego, ²Department of Electronic and Information Engineering, The Hong Kong Polytechnic University

4:10PM

3A.2

Vision-inspired Global Routing for Enhanced Performance and Reliability

Jun Yong Shin, Nikil Dutt, Fadi Kurdahi

UC Irvine

4:30PM

3A.3

Crosstalk Timing Windows Overlap in Statistical Static Timing Analysis

Hanif Fatemi and Peivand Tehrani

Synopsys, Inc.

4:50PM

3A.4

Multi-objective Optimization Algorithm for Efficient Pin-constrained Droplet Routing Technique in Digital Microfluidic Biochip

Soumyajit Chatterjee, Hafizur Rahaman, Tuhina Samanta

Bengal Engineering & Science University, Shibpur, Howrah, India

5:10PM

3A.5

Advances in Wire Routing

Martin D.F. Wong

University of Illinois at Urbana-Champaign

SESSION 3B

Tuesday March 5, 2013

Global Circuit Design

Chair: **Abhilash Goyal**, Oracle

Co-Chair: **Riaz Naseer**, Intel

3:50PM

3B.1

Effectiveness of Hybrid Recovery Techniques on Parametric Failures

Shrikanth Ganapathy¹, Ramon Canal¹, Antonio Gonzalez², Antonio Rubio³

¹Department of Computer Architecture, Universitat Politecnica de Catalunya, ²Intel Barcelona Research Center, ³Department of Electronic Engineering, Universitat Politecnica de Catalunya

4:10PM

3B.2

Fast Reliability Exploration for Embedded Processors via High-level Fault Injection

Zheng Wang, Chao Chen, Anupam Chattopadhyay

MPSoC Architectures, RWTH-Aachen

4:30PM

3B.3

Analysis and Reliability Test to Improve the Data Retention Performance of EPROM Circuits

Jiyuan Luan and Michael DiVita

Texas Instruments

4:50PM

3B.4

Enabling Sizing for Enhancing the Static Noise Margins

Valeriu Beiu¹, Azam Beg¹, Walid Ibrahim¹, Fekri Kharbash¹, Massimo Alioto²

¹UAEU, ²U Michigan Ann Arbor

5:10PM

3B.5

SRAM Bit-line Electromigration Mechanism and its Prevention Scheme

Zhong Guan¹, Malgorzata Marek-Sadowska¹, Sani Nassif²

¹Dept. of Electrical and Computer Engineering, UC Santa Barbara, ²IBM Austin Research Laboratory

SESSION 3C

Tuesday March 5, 2013

CAD for 3-D ICs

Chair: **Masahiro Fujita**, University of Tokyo

Co-Chair: **Anand Iyer**, AMD

3:50PM

3C.1

Cost-driven 3D Design Optimization with Metal Layer Reduction Technique

Qiaosha Zou¹, Jing Xie², Yuan Xie³

¹Pennsylvania State University, ²Penn State University, ³Penn State University and AMD research

4:10PM

3C.2

TSV-aware Topology Generation for 3D Clock Tree Synthesis

Wulong Liu¹, Haixiao Du¹, Yu Wang¹, Yuchuan Ma², Yuan Xie³, Jinguo Quan⁴, Huazhong Yang¹

¹Dept. of E.E., TNList, Tsinghua University, Beijing, China, ²Dept. of C.S., TNList, Tsinghua University, Beijing, China, ³Dept. of CSE, Pennsylvania State Univ., USA, ⁴Graduate School at Shenzhen, Tsinghua University, China

4:30PM

3C.3

Electrical and Thermal Analysis for Design Exchange Formats in Three Dimensional Integrated Circuits

Rishik Bazaz¹, Jianyong Xie¹, Madhavan Swaminathan²

¹Student, Georgia Institute of Technology, ²Professor, Fellow IEEE, Georgia Institute of Technology

4:50PM

3C.4

Reliability Consideration with Rectangle- and Double-Signal Through Silicon Vias Insertion in 3D Thermal-Aware Floorplanning

Chih-han Hsu, Shanq-Jang Ruan, Ying-Jung Chen, Tsang-Chi Kan

Department of Electronic Engineering National Taiwan University of Science and Technology, Taipei, Taiwan

5:10PM

3C.5

Configurable Redundant Via-Aware Standard Cell Design Considering Multi-Via Mechanism

Tsang-Chi Kan, Hung-Ming Hong, Ying-Jung Chen, Shanq-Jang Ruan

Department of Electronic and Computer Engineering, National Taiwan University of Science and Technology, Taipei, Taiwan

Poster Session & Mixer

Tuesday March 5, 2013

Chair: **Syed M Alam**, Everspin Technologies

Co-Chair: **Mark Budnik**, Valparaiso University

P.1

A Novel Flow for Reducing Clock Skew Considering NBTI Effect and Process Variations

Jifeng Chen and Mohammad Tehranipoor

University of Connecticut

P.2

Suspicious Timing Error Prediction with In-Cycle Clock Gating

Youhua Shi, Hiroaki Igarashi, Nozomu Togawa, Masao Yanagisawa

Waseda Univ.

P.3

Performance Entitlement by Exploiting Transistor's BTI Recovery

Senthil Arasu¹, Mehrdad Nourani¹, Vijay Reddy², John Carulli³

¹Univ. of Texas at Dallas, ²Texas Instruments Inc, Dallas, ³Texas Instruments Inc. Dallas

P.4

Device Design and Analysis of Logic Circuits and SRAMs for Germanium FinFETs on SOI and Bulk Substrates

Vita Pi-Ho Hu, Ming-Long Fan, Pin Su, Ching-Te Chuang

National Chiao Tung University

P.5

A Novel 6T SRAM Cell with Asymmetrically Gate Underlap Engineered FinFETs for Enhanced Read Data Stability and Write Ability

Shairfe Salahuddin, Hailong Jiao, Volkan Kursun

Department of Electronic and Computer Engineering, The Hong Kong University of Science and Technology

P.6

Canonical Ordering of Instances to Immunize the FPGA Place and Route Flow from ECO-Induced Variance

Avijit Dutta, Neil Tuttle, Krishnan Anandh

Cypress Semiconductor Corporation

P.7

Architecture for Monitoring SET Propagation in 16-bit Sklansky Adder

Varadan Savulimedu Veeravalli and Andreas Steininger

Vienna University of Technology

P.8

Application of Six-Sigma DMAIC Methodology in the Evaluation of Test Effectiveness: A Case Study for EDA Tools

Eman El Mandouh

Quality Assurance Manager , Mentor Graphics

P.9

A Low Power Deflection Routing Method for Bufferless NoC

Chung-Kai Hsu¹, Kun-Lin Tsa², Jing-Fu Jheng¹, Shanq-Jang Ruan¹, Chung-An Shen¹

¹National Taiwan University of Science and Technology, ²Tunghai University

P.10

A 64-core Platform for Biomedical Signal Processing

Jordan Bisasky¹, Houman Homayoun², Farhang Yazdani³, Tinoosh Mohsenin¹

¹Univ of Maryland - BC, ²George Mason University, ³BroadPak

P.11

Improving Timing Error Tolerance without Impact on Chip Area and Power Consumption

Ken Yano, Takanori Hayashida, Toshinori Sato

Fukuoka University

P.12

System-Level Modelling of Dynamic Reconfigurable Designs using Functional Programming Abstractions

Bahram Najafi Uchevler¹, Kjetil Svarstad¹, Jan Kuiper², Christiaan Baaij²

¹Department of Electronics and Telecommunication, NTNU, Norway, ²Department of Computer Science, University of Twente

P.13

Design of a 6 Gbps Continuous-Time Adaptive Equalizer Using a Voltage Rectifier Instead of a Power Detector

Krishna Srinivasan and Jonathan Rosenfeld

Intel Corporation

P.14

A Predictable Compact Model for Non-monotonous Vth-Pelgrom Plot of Long Channel Halo-implanted Transistors

Shigetaka Kumashiro

Renesas Electronics Corporation

P.15

Manufacturable Nanometer Designs using Standard Cells with Regular Layout

Kasyab Parmesh Subramaniyan and Per Larsson-Edefors

Chalmers University of Technology

P.16

Fast Analog Design Optimization using Regression-based Modeling and Genetic Algorithm: A Nano-CMOS VCO Case Study

Dhruva Ghai¹, Saraju Mohanty², Garima Thakral¹

¹Oriental University, Indore, India, ²University of North Texas, USA

P.17

Low Power Sensor for Temperature Compensation in Molecular Biosensing

Daniela De Venuto

Politecnico di Bari, Italy

P.18

A Power Efficient and Digitally Assisted CMOS Complementary Telescopic Amplifier with Wide Input Common Mode Range

Rishi Todani and Ashis Kumar Mal

National Institute of Technology, Durgapur

KEYNOTE SPEECHES

Plenary Session 2P

Wednesday March 6
Room: Silicon Valley
8:50AM-10:00AM

Keynote Speech 2P.1

Wednesday, March 6
9:00AM-9:30AM

Physical-Aware, High-Capacity RTL Synthesis for Advanced Nanometer Designs



Sanjiv Taneja
Vice President, Product Engineering
Cadence Design Systems

The small world of sub-20nm is already upon us and has brought a new set of challenges for RTL designers as the race for best PPA (performance, power, and area) continues unabated. Challenges include giga-scale integration of new functionality, new physics effects, new device structures such as FinFETs, interconnect stacks with vastly varying resistance characteristics from bottom to top layers in a non-linear fashion and process variation. These challenges are raising several questions. Can RTL synthesis handle giga-scale, giga-hertz designs in a timeframe of market relevance? Can logic synthesis perform accurate and predictive modeling of the interconnect stack, vias and other physical effects in RTL? How do new device structures affect dynamic and leakage power tradeoff and library choices? How do logic structuring, cell selection, clock gating, and DFT choices change to anticipate and handle routing congestion? And how do we ensure strong correlation between logic synthesis and P&R/signoff? This talk will explore these challenges and provide an overview of state-of-the-art technology to address them in a predictive and convergent design flow.

About Sanjiv Taneja

Sanjiv Taneja is VP of Product Engineering for the Front End Design Group at Cadence Design Systems. Prior to assuming this role in 2010, he led Cadence's Encounter Test R&D group for over five years. He joined Cadence from Bell Laboratories where he led the development of

transistor-sizing based technology for low power design. Sanjiv holds a BS degree in EE from IIT New Delhi, MS in Computer Science from Ohio State University and MBA from NYU.

Keynote Speech 2P.2

Wednesday, March 6
9:30AM-10:00AM

The Lifecycle of Audio Products, Consumer versus Professional



Perry Goldstein
Director of Sales & Marketing
Marshall Electronics

Most electronics will last many years if they are used in their intended manner. Professional electronics are not necessarily built to last longer, but to perform better. When they are built to meet the needs of the professional user, they will be in use for many more years than if a consumer product is used in a professional environment. This keynote provides a review of electronics lifecycle process, and the elements that make up the process, from a sales and marketing perspective. It will compare the design and lifecycle of consumer and professional electronics. The talk will further explore case studies of actual product applications.

About Perry Goldstein

Perry Goldstein is a veteran of the electronics industry. He spent his career in consumer electronics including 23 years at Panasonic. He is currently Director of Sales & Marketing for Marshall Electronics, manufacturer of broadcast monitors, and MXL recording microphones. He is also a professional speaker and writer for the digital signage industry.

SESSION 4A

Wednesday March 6, 2013

Low Power Technologies

Chair: **Syed M. Alam**, Everspin Technologies

Co-Chair: **Dinesh Somasekhar**, Intel

10:20AM

4A.1

Peak Power Reduction of a Sensor Network Processor Fabricated With Deeply Depleted Channel Transistors in 65nm Technology

Kentaro Kawakami, Takeshi Shiro, Hironobu Yamasaki, Katsuhiro Yoda, Hiroaki Fujimoto, Kenichi Kawasaki, Yasuhiro Watanabe

Fujitsu Laboratories Ltd.

10:40AM

4A.2

Evaluation of Tunnel FET-based Flip-Flop Designs for Low Power, High Performance Applications

Matthew Cotter, Huichu Liu, Suman Datta, Vijaykrishnan Narayanan

The Pennsylvania State University

11:00AM

4A.3

A Cost-effective 45nm 6T-SRAM Reducing 50mV V_{min} and 53% Standby Leakage with multi-V_t Asymmetric Halo MOS and Write Assist Circuitry

Koji Nii¹, Makoto Yabuuchi¹, Hidehiro Fujiwara¹, Yasumasa Tsukamoto¹, Yuichiro Ishii¹, Tetsuya Matsumura¹, Yoshio Matsuda²

¹Renesas Electronics Corporation, ²Kanazawa University

11:20AM

4A.4

CPDI: Cross-Power-Domain Interface Circuit Design in Monolithic 3D Technology

Jing Xie¹, Yang Du², Yuan Xie³

¹The Pennsylvania State University, ²Qualcomm, Inc., ³The Pennsylvania State University and
AMD Research

11:40AM

4A.5

Impact of Process Parameter and Supply Voltage Fluctuations on Multi-Threshold-Voltage Seven-Transistor Static Memory Cells

Hong Zhu and Volkan Kursun

Hong Kong University of Science and Technology

SESSION 4B

Wednesday March 6, 2013

Silicon Diagnosis and Test

Chair: **Sreejit Chakravarty**, LSI Logic

Co-Chair: **Srivatsa Vasudevan**, Synopsys

10:20AM

4B.1

Input-Aware Statistical Timing Analysis-Based Delay Test Pattern Generation

Bao Liu and Lu Wang

University of Texas at San Antonio

10:40AM

4B.2

Effect-Cause Intra-Cell Diagnosis at Transistor Level

Zhenzhou Sun¹, Alberto Bosio², Luigi Dilillo³, Patrick Girard³, Aida Todri³, Arnaud Viraze², Etienne Auvray⁴

¹LIRMM - ST, ²LIRMM - UM2, ³LIRMM - CNRS, ⁴ST

11:00AM

4B.3

Framework for Analog Test Coverage

Debesh Bhatta¹, Ishita Mukhopadhyay², Suriyaprakash Natarajan³, Prashant Goteti³, Bin

Xue³

¹Georgia Institute of Technology, ²Cornell University, ³Intel Corporation

11:20AM

4B.4

Fast FPGA-Based Fault Injection Tool for Embedded Processors

Mohammad Shokrolah Shirazi, Brendan Morris, Henry Selvaraj

University of Nevada, Las Vegas

11:40AM

4B.5

Diagnosis of Small Delay Defects Arising Due to Manufacturing Imperfections using Path Delay Measurements

Ahish Mysore Somashekar and Spyros Tragoudas

SIUC

SESSION 4C

Wednesday March 6, 2013

New Ideas in CAD

Chair: **James Lei**, Altera

Co-Chair: **Debasish Das**, Synopsys

10:20AM

4C.1

Tabu Search Based Cells Placement in Nanofabric Architectures with Restricted Connectivity

Sadiq M. Sait and Abdalrahman M. Arafeh

King Fahd University of Petroleum & Minerals

10:40AM

4C.2

Relocatable and Resizable SRAM Synthesis for Via Configurable Structured ASIC

Hsin-Hung Liu, Rung-Bin Lin, I-Lun Tseng

Yuan Ze University

11:00AM

4C.3

Cost-Efficient Scheduling in High-Level Synthesis for Soft-Error Vulnerability Mitigation

Yuko Hara-Azumi¹ and Hiroyuki Tomiyama²

¹Nara Institute of Science and Technology, ²Ritsumeikan University

11:20AM

4C.4

Analysis of Very Large Resistive Networks Using Low Distortion Embedding

Sandeep Koranne

Mentor Graphics Corporation

11:40AM

4C.5

Efficient Translation Validation of High-Level Synthesis

Tun Li, Yang Guo, Wanwei Liu, Chiyuan Ma

NUDT

SESSION 5A

Wednesday March 6, 2013

System Design Methodologies and Automation

Chair: **Makram Mansour**, Texas Instruments

Co-Chair: **Sudeep Pasricha**, Colorado State University

1:30PM

5A.1

Performance and Cache Access Time of SRAM-eDRAM Hybrid Caches Considering Wire Delay

Young-Ho Gong, Hyung Beom Jang, Sung Woo Chung

Department of Computer and Radio Communication Engineering, Korea University

1:50PM

5A.2

Increasing the Security Level of Analog IPs by Using a Dedicated Vulnerability Analysis

Methodology

Noemie Beringuier-Boher¹, David Hely², Vincent Beroulle², Joel Damiens³, Philippe Candelier³

¹Grenoble-INP LCIS and STMicroelectronics, ²Grenoble-INP LCIS, ³STMicroelectronics

2:10PM

5A.3

High-speed DFG-level SEU Vulnerability Analysis for Applying Selective TMR to Resource-Constrained CGRA

Takashi Imagawa, Hiroshi Tsutsui, Hiroyuki Ochi, Takashi Sato

Kyoto University

2:30PM

5A.4

Geostatistics Inspired Fast Layout Optimization of Nanoscale CMOS Phase Locked Loop

Oghenekarho Okobiah, Saraju Mohanty, Elias Kougianos

University of North Texas, Denton

2:50PM

5A.5

A Method to Determine the Sensitization Probability of a Non-Robustly Testable Path

Dheepakumaran Jayaraman and Spyros Tragoudas

Southern Illinois University Carbondale

3:10PM

5A.6

Early System Level Modeling of Real-time Applications on Embedded Platforms

Richard Lee¹, Karim Abdel-Khalek¹, Frederic Risacher², Samar Abdi¹

¹Concordia University, ²Research In Motion

SESSION 5B

Wednesday March 6, 2013

Manufacturing and Modeling Issues of Nanoscale CMOS

Chair: **Mustafa Yelten**, Intel

Co-Chair: **Rajan Beera**, Texas Instruments

1:30PM

5B.1

SUALD: Spacing Uniformity-Aware Layout Decomposition in Triple Patterning

Lithography

Zihao Chen¹, Hailong Yao², Yici Cai²

¹Tsinghua University, China, and Department of Microelectronics, Peking University, Beijing 100871, China, ²Tsinghua University, China

1:50PM

5B.2

Stochastic Behavioral Modeling of Analog/Mixed-Signal Circuits by Maximizing Entropy

Rahul Krishnan¹, Wei Wu¹, Fang Gong¹, Lei He²

¹Student Member, IEEE, ²Senior Member, IEEE

2:10PM

5B.3

Analysis, Modeling and Silicon Correlation of Low-voltage Flop Data Retention in 28nm Process Technology

Animesh Datta, Mohamed Abu-Rahma, Sachin Dasnurkar, Hadi Rasouli, Sean Tamjidi, Ming Cai, Samit Sengupta, PR Chidambaram, Raghavan Thirumala, Nikhil Kulkarni, Prasanna Seeram, Prasad Bhadri, Prayag Patel, Sei Seung Yoon, Esin Terzioglu

Qualcomm

2:30PM

5B.4

A Comparator Energy Model Considering Shallow Trench Isolation Stress by Geometric Programming

Gong Chen¹, Yu Zhang¹, Bo Yang², Qing Dong¹, Shigetoshi Nakatake¹

¹The University of Kitakyushu, ²Design Algorithm Laboratory, Inc.

2:50PM

5B.5

Wire Delay Variability in Nanoscale Technology and Its Impact on Physical Design

Sani Nassif, Gi-Joon Nam, Shayak Banerjee

IBM Research

3:10PM

5B.6

Multi-trap RTN Parameter Extraction based on Bayesian Inference

Hiroimitsu Awano, Hiroshi Tsutsui, Hiroyuki Ochi, Takashi Sato

Kyoto University

SESSION 5C

Wednesday March 6, 2013

Multi-core and Multi-processor Systems

Chair: **Bin Wu**, AMD

Co-Chair: **Amir Ajami**, Synopsys

1:30PM

5C.1

VERVE: A Framework for Variation-Aware Energy Efficient Synthesis of NoC-based MPSoCs with Voltage islands

Nishit Kapadia and Sudeep Pasricha

Colorado State University

1:50PM

5C.2

A Virtualization Approach for MIPS-based MPSoCs

Alexandra Aguiar, Carlos Moratelli, Marcos Sartori, Fabiano Hessel

PUCRS

2:10PM

5C.3

Thermal-Aware Semi-Dynamic Power Management for Multicore Systems with Energy Harvesting

Yi Xiang and Sudeep Pasricha

Colorado State University

2:30PM

5C.4

On the Interactions Between Real-Time Scheduling and Inter-thread Cache Interferences for Multicore Processors

Yiqiang Ding and Wei Zhang

Virginia Commonwealth University

2:50PM

5C.5

Resource Allocation and Consolidation in a Multi-Core Server Cluster Using a Markov Decision Process Model

Yanzhi Wang, Shuang Chen, Hadi Goudarzi, Massoud Pedram

University of Southern California

3:10PM

5C.6

Reliability-Aware and Energy-Efficient Synthesis of NoC based MPSoCs

Yong Zou and Sudeep Pasricha

Mr.

SESSION 6A

Wednesday March 6, 2013

Issues and Challenges in Characterization and Power Integrity for Nanometer Technologies

Chair: **Srini Krishnamoorthy**, AMD

Co-Chair: **Vamsi Srikantam**, Applied Micro

3:50PM

6A.1

CMOS Inverter Delay Model Based on DC Transfer Curve for Slow Input

Felipe Marranghello, André Reis, Renato Ribas

UFRGS

4:10PM

6A.2

RF Passive Device Modeling and Characterization in 65nm CMOS Technology

Errikos Lourandakis, Stefanos Stefanou, Konstantinos Nikellis, Sotiris Bantas

Helic Inc.

4:30PM

6A.3

An Efficient Method for ECSM Characterization of CMOS Inverter in Nanometer Range Technologies

Baljit Kaur¹, Sandeep Miryala², Sanjeev Kumar Manhas¹, Anand Bulusu¹

¹Indian Institute of Technology, Roorkee, India, ²politecnico di torino, torino

4:50PM

6A.4

Power Integrity Analysis and Discrete Optimization of Decoupling Capacitors on High Speed Power Planes by Particle Swarm Optimization

Jai Narayan Tripathi¹, Raj Kumar Nagpal², Nitin Kumar Chhabra², Rakesh Malik², Jayanta Mukherjee¹, Prakash R. Apte¹

¹IIT Bombay, ²STMicroelectronics Pvt. Ltd.

5:10PM

6A.5

A Method to Determine the Sensitization Probability of a Non-Robustly Testable Path

Dheepakumaran Jayaraman¹ and Spyros Tragoudas²

¹Nvidia Corporation, ²Southern Illinois University, Carbondale

SESSION 6B

Wednesday March 6, 2013

Low Power Circuits

Chair: **Dinesh Somasekhar**, Intel

Co-Chair: **Amin Khajeh Djahromi**, Intel

3:50PM

6B.1

A Power-Efficient On-Chip Linear Regulator Assisted by Switched Capacitors for Fast Transient Regulation

Suming Lai and Peng Li

Texas A&M University

4:10PM

6B.2

A Versatile Rail to Rail Current Mode Instrumentation Amplifier with an Embedded Band - pass Filter for Bio-potential Signal Conditioning

Anvesha Amaravati and Maryam Shojaei Baghini

IIT-Bombay

4:30PM

6B.3

A 0.2nJ/sample 0.01mm² Ring Oscillator Based Temperature Sensor for On-Chip Thermal Management

Nicolo Testi and Yang Xu

ECE Department, Illinois Institute of Technology

4:50PM

6B.4

Analysis and Comparison of XOR Cell Structures for Low Voltage Circuit Design

Shinichi Nishizawa, Tohru Ishihara, Hidetoshi Onodera

Kyoto University

5:10PM

6B.5

A CMOS High Dimming Ratio Power-LED Driver with a Preloading Inductor Current

Method

Kwang Yoon and Keon Lee

Inha University

SESSION 6C

Wednesday March 6, 2013

Reliable System Design

Chair: **Mustafa Yelten**, Intel

Co-Chair: **Srivinas Bodapati**, Intel

3:50PM

6C.1

Protection of Muller-Pipelines from Transient Faults

Syed Rameez Naqvi, Jakob Lechner, Andreas Steininger

Embedded Computing Systems, Vienna University of Technology, Vienna, Austria

4:10PM

6C.2

Minimizing Simultaneous Switching Noise at Reduced Power with Constant-Voltage Power Transmission Lines for High-Speed Signaling

Satyanarayana Telikepalli, Madhavan Swaminathan, David Keezer

Dept. of Electrical & Computer Engineering, Georgia Institute of Technology

4:30PM

6C.3

Reliable Express-Virtual-Channel-based Network-on-Chip under the Impact of Technology Scaling

Xin Fu¹, Tao Li², Jose Fortes²

¹University of Kansas, ²University of Florida

4:50PM

6C.4

Clustering Techniques and Statistical Fault Injection for Selective Mitigation of SEUs in Flip-Flops

Adrian Evans¹, Michael Nicolaidis², Shi-Jie Wen³, Thiago Assis⁴

¹iRoC Technologies, ²Institut National Polytechnique de Grenoble, ³Cisco Systems, ⁴Vanderbilt University

5:10PM

6C.5

Easy-to-Build Arbiter Physical Unclonable Function with Enhanced Challenge/Response Set

Dinesh Ganta and Leyla Nazhandali

Virginia Tech

